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Application Number	09489286
Filing Date	2000-01-21
First Named Inventor	David A. Cathey
Art Unit	2879
Examiner Name	A. Patel
Attorney Docket Number	2269-7129.2US(95-0582.02/)

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/AP/	4	Evtukh et al. Jul. 30, 1995, "Parameters of the Tip Arrays Covered by Low Work Function Layers," Institute of Semiconductor Physics Academy of Sciences, Prospect Nauki 45, Kiev-252028, Ukraine (Aug. 1995).	<input type="checkbox"/>

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/AP/	5	Evtukh, et al. "Parameters of the Tip Arrays Covered by Low Work Function Layers," J. Vac. Sci Tech. B 14 (3), pp. 2130-2134, (Pub. May-June 1996). <input type="checkbox"/>
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